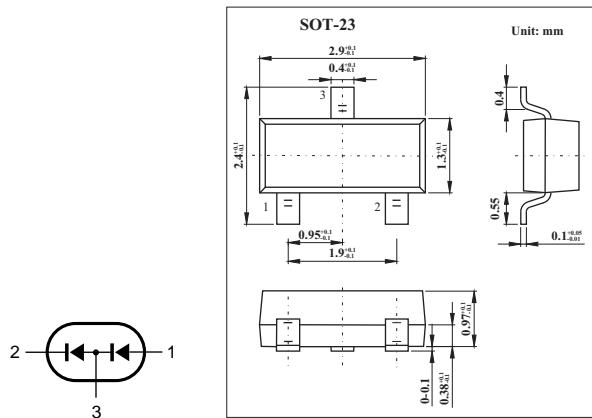


General Purpose PIN Diode

BAP50-04

■ Features

- Low diode capacitance.
- Low diode forward resistance.



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Continuous reverse voltage	V _R	50	V
Continuous forward current	I _F	50	mA
Total power dissipation Ts = 90°C	P _{tot}	250	mW
Storage temperature	T _{stg}	-65 to +150	°C
Junction temperature	T _j	150	°C
Thermal resistance from junction to soldering point	R _{th j-s}	220	°C/W

■ Electrical Characteristics Ta = 25°C

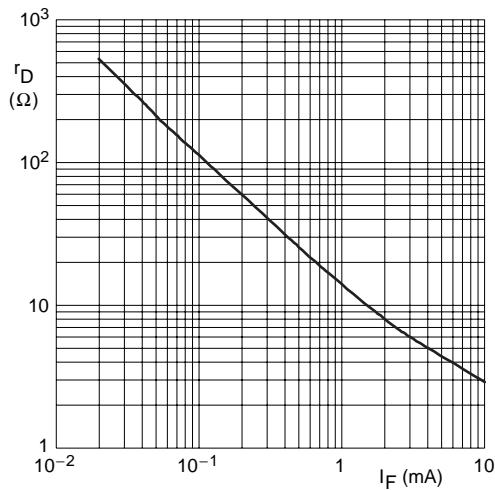
Parameter	Symbol	Test conditons	Min	Typ	Max	Unit
Forward voltage	V _F	I _F = 50 mA		0.95	1.1	V
Reverse voltage	V _R	I _R = 10 μA	50			V
Reverse current	I _R	V _R = 50 V		100	nA	
Diode capacitance	C _d	V _R = 0; f = 1 MHz		0.45		pF
		V _R = 1 V; f = 1 MHz		0.35	0.5	pF
		V _R = 5 V; f = 1 MHz		0.3	0.5	pF
Diode forward resistance	r _D	I _F = 0.5 mA; f = 100 MHz	25	40		Ω
		I _F = 1 mA; f = 100 MHz	14	25		Ω
		I _F = 10 mA; f = 100 MHz	3	5		Ω

■ Marking

Marking	4LP
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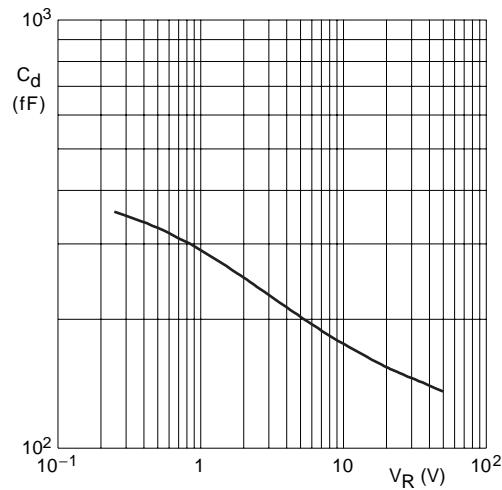
BAP50-04

■ Typical Characteristics



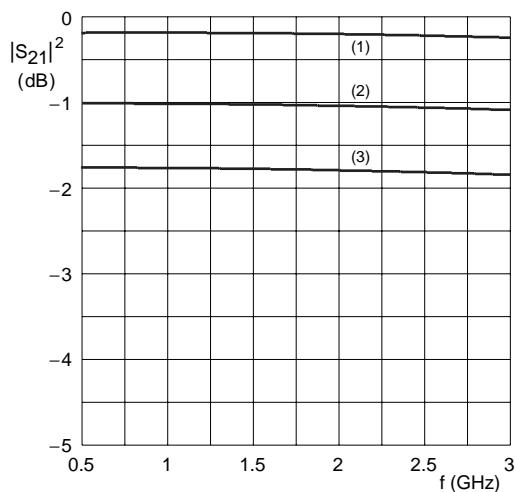
$f = 100 \text{ MHz}; T_j = 25^\circ\text{C}.$

Fig.1 Forward resistance as a function of the forward current; typical values.



$f = 1 \text{ MHz}; T_j = 25^\circ\text{C}.$

Fig.2 Diode capacitance as a function of reverse voltage; typical values.

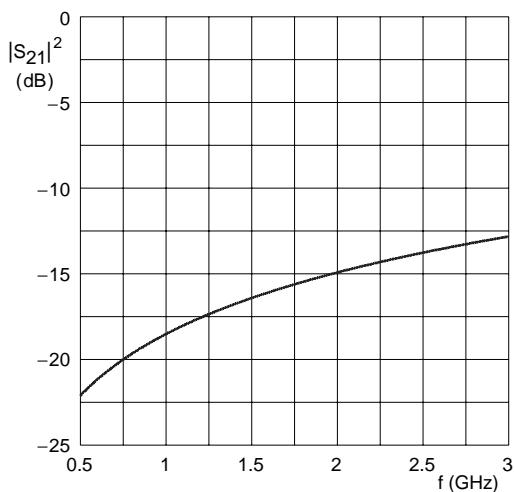


(1) $I_F = 10 \text{ mA}$. (2) $I_F = 1 \text{ mA}$. (3) $I_F = 0.5 \text{ mA}$.

Diode inserted in series with a 50 Ω stripline circuit and biased via the analyzer Tee network.

$T_{\text{amb}} = 25^\circ\text{C}$.

Fig.3 Insertion loss ($|S_{21}|^2$) of the diode in on-state as a function of frequency; typical values.



Diode zero biased and inserted in series with a 50 Ω stripline circuit.
 $T_{\text{amb}} = 25^\circ\text{C}$.

Fig.4 Isolation ($|S_{21}|^2$) of the diode in off-state as a function of frequency; typical values.